

**Search Notes**

Application/Control No.

10/025,390

Examiner

Isaac M. Woo

Applicant(s)/Patent under  
Reexamination

FRENCH ET AL.

Art Unit

2162

**SEARCHED**

Class	Subclass	Date	Examiner
707	1-10	6/29/2005	IW
707	100-104.1	6/29/2005	IW
707	200-206	6/29/2005	IW

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (USPAT, US-PGPUB, EPO , JPO, DERWENT, IBM_TDB)	6/29/2005	IW